	Correction.						
Form PTO 1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.	
(Modified)				250833US2		10/805,362	
		SIP	E ve	APPLICANT			
LIST OF	REFE	RENCES CITED OF AP		Yohichiro MIYAGUCHI, et al.			
(nu 5: 8: 500x 22)				FILING DATE		GROUP	
				March 22, 2004		2852	
EXAMINER DOCUMENT U.S. PATENT DOCUMENTS SUB FILING DATE							
EXAMINER			DATE	NAME	CLASS	SUB	FILING DATE
INITIAL		NUMBER	 			CLASS	IF APPROPRIATE
TMR	AA	6,367,914	04/09/02	OHTAKA et al.			
TAR	AB	5,412,413	05/02/95	SEKIYA et al.			
TMR	AC	5,600,356	02/04/97	SEKIYA et al.			
TMR	AD	4,847,631	07/11/89	NARUSE et al.			
TMR	AE	5,317,438	05/31/94	SUZUKI et al.			
TMR	AF	6,597,884	07/22/03	MIYAGUCHI et al.			
TMR	AG	6,708,014	03/16/04	MIYAGUCHI et al.			
	AH				ļ		
	AI						
	AJ						
	AK						
	AL				ļ		
	АМ				<u> </u>		
	AN		L		<u>!</u>	<u> </u>	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
	AO		1				
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY			,			
	AZ				Addi	tional Refe	rences sheet(s) attached
Examiner	7	Varia Rom			Date Considered 7/11/5		
*Examiner: Initial If reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							